Amendments to the Claims

1.	(Canceled)		
2.	(Canceled)		
3.	(Canceled)		
4.	(Canceled)		
5.	(Canceled)		
6.	(Canceled)		
7.	(Canceled)		
8.	(Canceled)		
9.	(Canceled)		
10). (Canceled)		
11	1 (Canceled)		

- 12. (Canceled)
- 13. (Canceled)
- 14. (Canceled)
- 15. (Canceled)
- 16. (Canceled)
- 17. (Canceled)
- 18. (Canceled)
- 19. (Canceled)
- 20. (Canceled)
- 21. (Canceled)
- 22. (Canceled)
- 23. (Canceled)

24. (Canceled)
25. (Canceled)
26. (Canceled)
27. (Canceled)
28. (Canceled)
29. (Canceled)
30. (Canceled)
31. (Canceled)
32. (Canceled)
33. (Currently Amended) The A method of Claim 32, for optical system coherence
testing, comprising the steps of:
a. in an optical system, aligning a light source with an apparatus designed

for optical system coherence testing and with a means to observe interference patterns;

- <u>b.</u> <u>transmitting light through the apparatus designed for optical system</u> coherence testing; and
- c. observing interference patterns from said transmitted light with the means to observe interference patterns;

wherein said aligning provides that light incident upon the apparatus designed for optical system coherence testing is at a non-perpendicular angle.

- 34. (Currently Amended) The A method of Claim 32, for optical system coherence testing, comprising the steps of:
- a. in an optical system, aligning a light source with an apparatus designed for optical system coherence testing and with a means to observe interference patterns;
- b. <u>transmitting light through the apparatus designed for optical system</u> coherence testing; and
- c. <u>observing interference patterns from said transmitted light with the means</u> to observe interference patterns;

wherein said aligning provides that light incident upon the means to observe interference patterns is at a non-perpendicular angle.

- 35. (Original) The method of Claim 34, wherein said aligning is provided by a wedge-shaped transmissive crystal.
- 36. (Original) The method of Claim 34, wherein said aligning is provided by a transmissive piezoelectric crystal.

- 37. (Original) The method of Claim 34, wherein said aligning is provided by a piezoelectric spacer.
- 38. (Canceled)
- 39. (Canceled)
- 40. (Canceled)
- 41. (Currently Amended) The A method of Claim 38, for optical system coherence testing, comprising the steps of:
- a. in an optical system, aligning a light source with an apparatus designed for optical system coherence testing and with a means to observe interference patterns;
- <u>b.</u> <u>transmitting light through the apparatus designed for optical system</u> <u>coherence testing; and</u>
- c. <u>observing interference patterns from said transmitted light with the means</u> to observe interference patterns;

wherein the apparatus designed for optical system coherence testing simultaneously tests for both horizontal and vertical spatial coherence.

- 42. (Currently Amended) The method of Claim 32 41, wherein the apparatus designed for optical system coherence testing tests for temporal (longitudinal) coherence.
- 43. (Canceled)

- 44. (Currently Amended) The A method of Claim 32, for optical system coherence testing, comprising the steps of:
- <u>a.</u> <u>in an optical system, aligning a light source with an apparatus designed</u> for optical system coherence testing and with a means to observe interference patterns;
- b. transmitting light through the apparatus designed for optical system coherence testing; and
- c. <u>observing interference patterns from said transmitted light with the means</u> to observe interference patterns;

wherein the means to observe interference patterns is a recording medium.

- 45. (Original) The method of Claim 44, wherein the recording medium is photographic.
- 46. (Original) The method of Claim 44, wherein the recording medium is electronic.
- 47. (Currently Amended) The A method of Claim 32, for optical system coherence testing, comprising the steps of:
- a. in an optical system, aligning a light source with an apparatus designed for optical system coherence testing and with a means to observe interference patterns;
- b. transmitting light through the apparatus designed for optical system coherence testing; and
- c. observing interference patterns from said transmitted light with the means to observe interference patterns;

wherein the means to observe interference patterns is visual observation facilitated by a demodulator reticle.

This listing of claims will replace all prior versions, and listings of claims in the application.